Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/790,222	NAKAGAWA, YUJI	
Examiner	Art Unit	
Lv D. Pham	2827	

SEARCHED				
Class	Subclass	Date	Examiner	
365	230.03, 201, 230.06, 230.08	9/9/2005	LP	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH (INCLUDING SEAR		
	DATE E	XMR
East text search	9/9/2005	LP
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